	Application No.	Applicant(s)
Notice of Allowability	09/780,423	INUKAI, ATSUOMI
	Examiner	Art Unit
	Jeff Piziali	2629
The MAILING DATE of this communication apperation apperation allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313 1. This communication is responsive to the Amendment filed	(OR REMAINS) CLOSED in or other appropriate commits GHTS. This application is and MPEP 1308.	n this application. If not included
2. The allowed claim(s) is/are 1-10 and 12-21 (renumbered as		
 Acknowledgment is made of a claim for foreign priority una a)	been received. been received in Application cuments have been received of this communication to file ENT of this application.	on No ed in this national stage application from the e a reply complying with the requirements AMINER'S AMENDMENT or NOTICE OF
 CORRECTED DRAWINGS (as "replacement sheets") mus (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the deposed of the property of the deposed attached Examiner's comment regarding REQUIREMENT for the deposed of the property of t	on's Patent Drawing Revie Amendment / Comment o 84(c)) should be written on the header according to 37 Cl sit of BIOLOGICAL MAT	r in the Office action of the drawings in the front (not the back) of FR 1.121(d). ERIAL must be submitted. Note the
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/06 Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview S Paper No. 8), 7. ☐ Examiner's	Informal Patent Application (PTO-152) Jegummary (PTO-413), //Mail Date Amendment/Comment Statement of Reasons for Allowance Jeff Piziali 19 September 2006

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed (on 17 July 2006) in this application after final rejection (mailed 17 February 2006). Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's Amendment filed on 19 June 2006 has been entered.

Priority

2. Receipt is acknowledged of papers submitted under 35 U.S.C. 119(a)-(d), which papers have been placed of record in the file.

Allowable Subject Matter

- 3. Claims 1-10 and 12-21 (renumbered as claims 1-20) are allowed.
- 4. The following is an examiner's statement of reasons for allowance:

The present invention comprises a pointing device. The closest prior art, Maeda (US 6,512,510) discloses a pointing device [Figs. 1 & 3; P1] including: a sensor substrate [Figs. 2 & 3; 8] having a flat board form; a stick member [Fig. 3; 2] vertically provided on one surface of the sensor substrate; first [Fig. 3; 9a & 9c] and second [Fig. 3; 9b & 9d] pairs of strain sensors

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formed on another surface of the sensor substrate that is opposite to the one surface on which the stick member is provided, the strain sensors in the first pair and the second pair being respectively arranged in symmetrical relation to each other with respect to the stick member; and slits [Fig. 3; 6 & 8d] formed in the sensor substrate, each slit being constructed from a first slit portion positioned at a side of one of the strain sensors in the first pair and a second slit portion positioned at a side of one of the strain sensors in the second pair, the first slit portion and the second slit portion being connected to form the slit in an L-shape (see Column 5, Line 34 - Column 6, Line 64).

However, Maeda does not expressly teach a stick member vertically provided on one surface of the sensor substrate, a portion of a bottom surface of the stick member in direct contact with the one surface of the sensor substrate. This distinct structural arrangement has been incorporated into the pending independent claims (i.e. claims 1, 14, 15, and 21), thereby rendering them allowable.

Any comments considered necessary by the applicants must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jeff Piziali whose telephone number is (571) 272-7678. The examiner can normally be reached on Monday - Friday (6:30AM - 3PM).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Bipin Shalwala can be reached on (571) 272-7681. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Jeff Piziali

19 September 2006

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